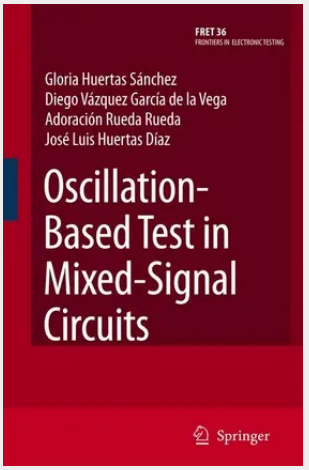
Huertas Sánchez / Vázquez García de la Vega / Rueda Rueda

Oscillation-Based Test in Mixed-Signal Circuits

Oscillation-Based Test in Mixed-Signal Circuits presents the development and experimental validation of the structural test strategy called Oscillation-Based Test – OBT in short. The results here presented allow to assert, not only from a theoretical point of view, but also based on a wide experimental support, that OBT is an efficient defect-oriented test solution, complementing the existing functional test techniques for mixed-signal circuits.

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160,49 €
149,99 € (zzgl. MwSt.)

Lieferfrist: bis zu 10 Tage

Artikelnummer: 9789048173365
Medium: Buch
ISBN: 978-90-481-7336-5
Verlag: Springer
Erscheinungstermin: 23.11.2010
Sprache(n): Englisch
Auflage: 1. Auflage. Softcover version of original hardcover Auflage 2006
Serie: Frontiers in Electronic Testing
Produktform: Kartoniert
Gewicht: 703 g
Seiten: 452
Format (B x H): 155 x 235 mm

Kundenservice Verlag Dr. Otto Schmidt KG
Neumannstraße 10, 40235 Düsseldorf | kundenservice@otto-schmidt.de | 0221-93738-997 (Inland)